



**Smart Cards;
Test specification for the
Single Wire Protocol (SWP) interface;
Part 2: UICC features
(Release 12)**

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(standards.iteh.ai)
Full standard:
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The present document is part 2 of a multi-part deliverable covering the Test specification for the Single Wire Protocol (SWP) interface, as identified below:

Part 1: "Terminal features";

Part 2: "UICC features".

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Introduction

The present document defines test cases for the UICC relating to Single Wire Protocol (SWP). SWP is the communication interface between the UICC and a contactless frontend (CLF) as specified in ETSI TS 102 613 [1].

The aim of the present document is to ensure interoperability between the terminal and the UICC independently of the respective manufacturer, card issuer or operator.

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Full standard:
<https://standards.iteh.ai/catalog/standards/sist/8212574b-40f8-40c9-a1d5-a320b46c389/etsi-ts-102-694-2-v12.0.0-2019-08>